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UniFET

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FDB52N20 200V N-Channel MOSFET

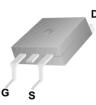
Features

- 52A, 200V, $R_{DS(on)} = 0.049\Omega @V_{GS} = 10 V$
- Low gate charge (typical 49 nC)
- Low C_{rss} (typical 66 pF)
- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



G O S

Absolute Maximum Ratings

Symbol	Parameter			FDB52N20	Unit	
V _{DSS}	Drain-Source Voltage			200	V	
I _D	Drain Current	- Continuous (T _C = 25° - Continuous (T _C = 100		52 33	A A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	208	A	
V _{GSS}	Gate-Source voltage			±30	V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	2520	mJ	
I _{AR}	Avalanche Current		(Note 1)	52	A	
E _{AR}	Repetitive Avalance	he Energy	(Note 1)	35.7	mJ	
dv/dt	Peak Diode Recov	ery dv/dt	(Note 3)	4.5	V/ns	
P _D	Power Dissipation $(T_C = 25^{\circ}C)$ - Derate above $25^{\circ}C$			357 2.86	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
Τ _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		rpose,	300	°C	

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		0.35	°C/W
R _{θJA} *	Thermal Resistance, Junction-to-Ambient*		40	°C/W
$R_{ extsf{ heta}JA}$	R _{0JA} Thermal Resistance, Junction-to-Ambient		62.5	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB52N20	FDB52N20TM	D ² -PAK	330mm	24mm	800

Electrical Characteristics T_c = 25°C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
Off Charac	teristics				L	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250 \mu A$	200			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, Referenced to $25^{\circ}C$			0.2		V/°C
I _{DSS}	Zero Gate Voltage Drain Current $V_{DS} = 200V, V_{GS} = 0V$ $V_{DS} = 160V, T_C = 125^{\circ}C$				1 10	μΑ μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 26A		0.041	0.049	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 26A$ (Note 4)		35		S
Dynamic C	haracteristics					•
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		2230	2900	pF
C _{oss}	Output Capacitance	f = 1.0MHz		540	700	pF
C _{rss}	Reverse Transfer Capacitance			66	100	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 100V, I _D = 52A		53	115	ns
t _r	Turn-On Rise Time	$R_{G} = 25\Omega$		175	359	ns
t _{d(off)}	Turn-Off Delay Time			48	107	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		29	68	ns
Qg	Total Gate Charge	V _{DS} = 160V, I _D = 52A		49	63	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V		19		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		24		nC
-	rce Diode Characteristics and Maximur	n Ratings				•
I _S	Maximum Continuous Drain-Source Diode Forward Current				52	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				204	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 52A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 52A		162		ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt =100A/μs (Note 4)		1.3		μC

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

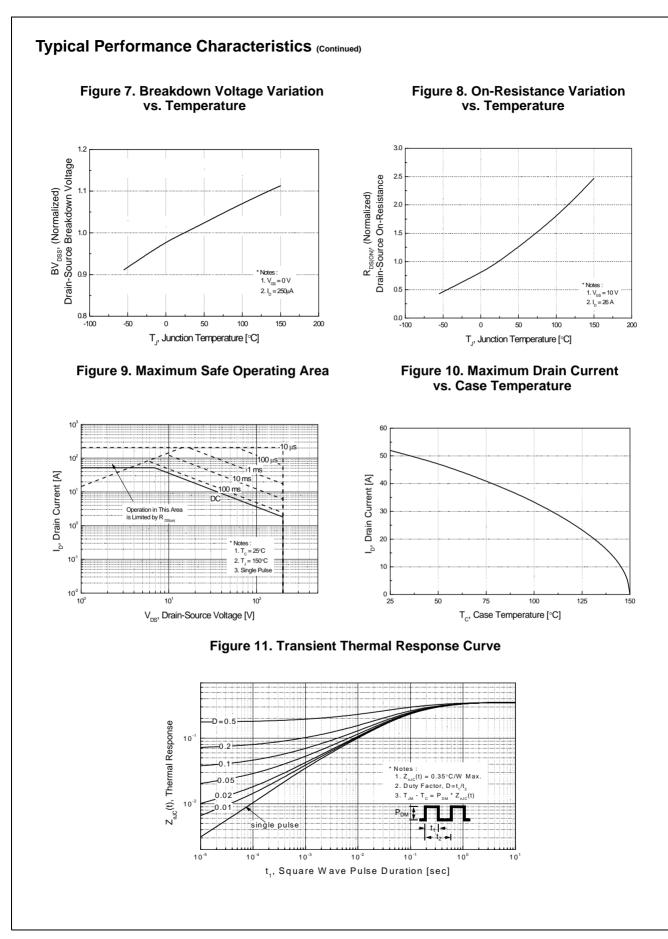
2. L = 1.4mH, I_{AS} = 52A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

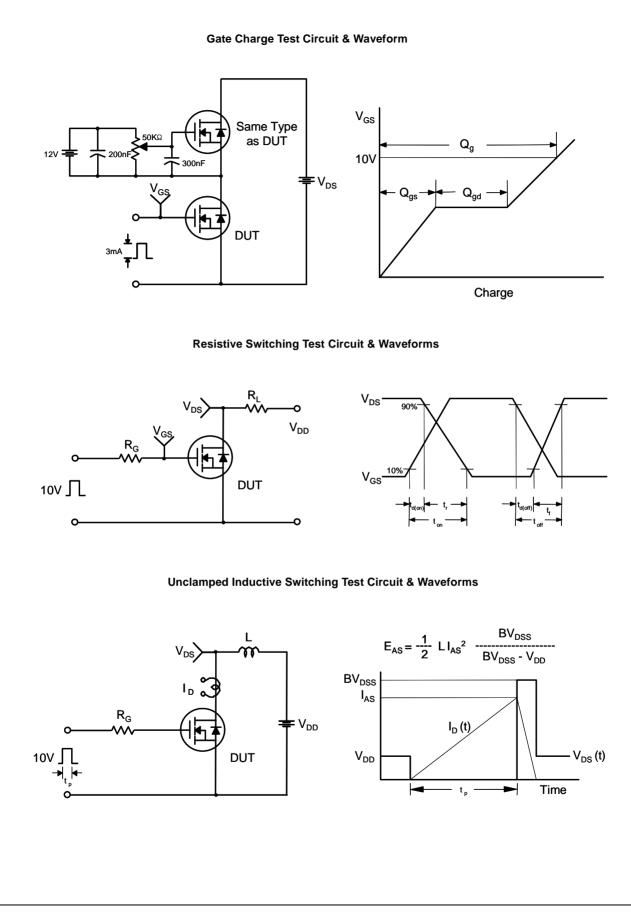
3. I_{SD} \leq 52A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}, Starting T_J = 25^{\circ}C

4. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 2%

5. Essentially Independent of Operating Temperature Typical Characteristics

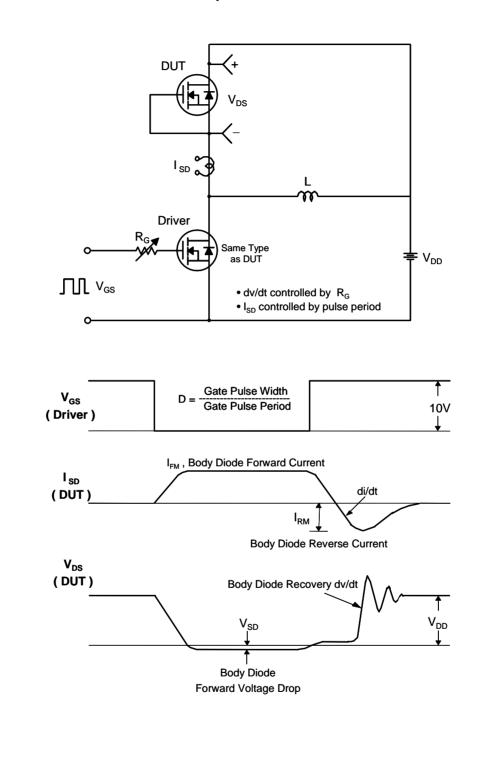
Typical Performance Characteristics Figure 1. On-Region Characteristics Figure 2. Transfer Characteristics V_{gs} 15.0 V 10.0 V Тор 10² 10 8.0 V 7.0 V 6.5 V 6.0 V I_D, Drain Current [A] I_b, Drain Current [A] 5.5 10 150°C 10 -55°C 10 Notes 1. V_{DS} = 40V 2. 250µs Pulse Test 1. 250µs Pulse Tes 2. T_c = 25°C 10 10[°] 10-1 100 10¹ 10 2 12 V_{DS}, Drain-Source Voltage [V] V_{GS}, Gate-Source Voltage [V] Figure 3. On-Resistance Variation vs. Figure 4. Body Diode Forward Voltage Drain Current and Gate Voltage Variation vs. Source Current and Temperatue 0.12 10 0.10 R_{DS(ON)} [Ω], Drain-Source On-Resistance Reverse Drain Current [A] 0.08 = 10V٧... 0.06 10 150°C 0.04 $V_{gs} = 20V$ 0.02 Notes : Ę, 1. V_{GS} = 0V 2. 250μs Pulse Test * Note : T, = 25°C 10⁰ ⊾ 0.2 0.00 ັດ 25 50 75 100 125 150 1.6 0.4 0.6 0.8 1.0 1.2 1.4 1.8 I_D, Drain Current [A] V_{sp}, Source-Drain voltage [V] **Figure 5. Capacitance Characteristics Figure 6. Gate Charge Characteristics** 12 6000 + C. $V_{DS} = 40V$ 10 5000 Gate-Source Voltage [V] V_{DS} = 100V V_{DS} = 160 8 4000 Capacitances [pF] 6 3000 2000 Note ; 1. V_{GS} = 0 V 2. f = 1 MHz $^{\sf SS'}$ 1000 2 * Note : I_D = 52A 0 0 10 10 10 20 30 40 50 60 V_{ps}, Drain-Source Voltage [V] Q_G, Total Gate Charge [nC]



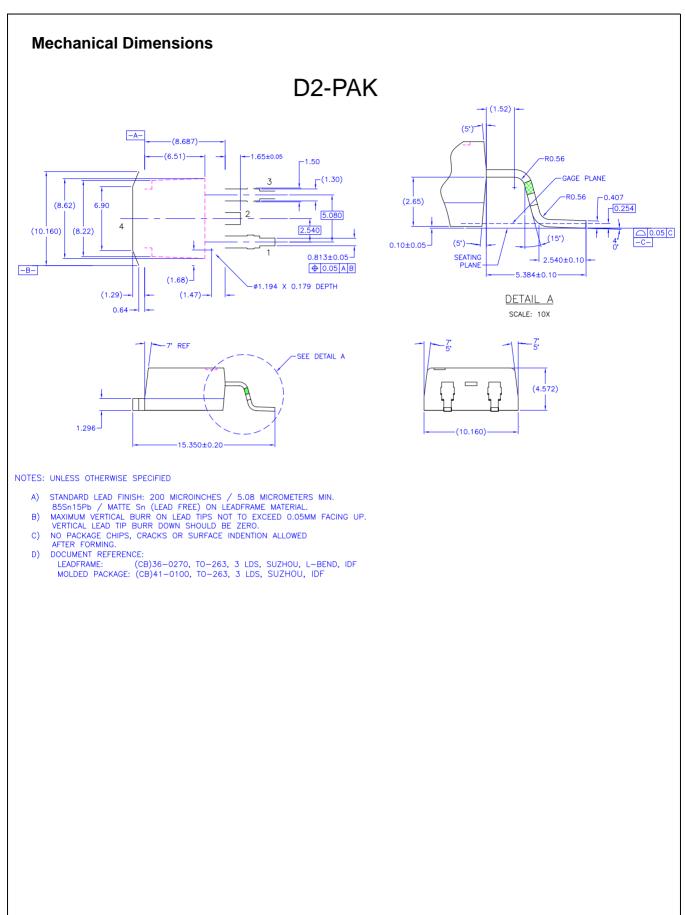


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Peak Diode Recovery dv/dt Test Circuit & Waveforms









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